

Application/Control No.	Applicant(s)/Patent under Reexamination
10/722,804	PATINO ET AL.
Examiner	Art Unit
Yalkew Fantu	2838

	SEAR	CHED	
Class	Subclass	Date	Examiner
320	121,125,1 29,153,10 6	4/16/2007	YF

INI	ERFERENC	E SEARCH	1ED
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC	OTES H STRATEGY	)
	DATE	EXMR
AST search history with text	4/16/2007	YF
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